

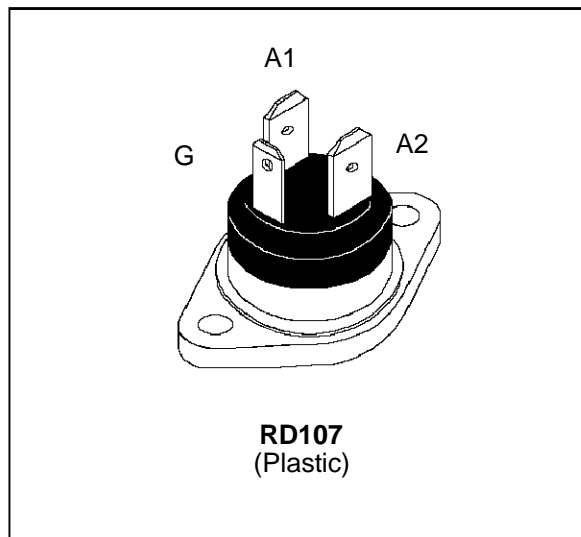
**SNUBBERLESS TRIACS**

**FEATURES**

- $I_{T(RMS)} = 25A$
- HIGH COMMUTATION :  
( $di/dt$ )<sub>c</sub> ≥ 12A/ms T2514xKS  
                                  ≥ 22A/ms T2516xKS
- INSULATING VOLTAGE = 2500V<sub>(RMS)</sub>  
(UL RECOGNIZED : E81734)

**DESCRIPTION**

The T2514/T2516xKS series of isolated triacs uses a high performances MESA GLASS technology. The SNUBBERLESS™ concept offer suppression of RC network and it is suitable for application such as phase control and static switching on inductive or resistive load.



**ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter		Value	Unit
$I_{T(RMS)}$	RMS on-state current (360° conduction angle)	$T_c = 85^{\circ}C$	25	A
$I_{TSM}$	Non repetitive surge peak on-state current ( $T_j$ initial = 25°C)	$t_p = 8.3ms$	260	A
		$t_p = 10ms$	250	
$I^2t$	$I^2t$ vakué for fusing	$t_p = 10ms$	312	A <sup>2</sup> s
$di/dt$	Critical rate of rise of on-state current $I_G = 500mA$ $dI_G/dt = 1A/\mu s$	Repetitive $F = 50Hz$	20	A/ $\mu s$
		Non repetitive	100	
$T_{stg}$ $T_j$	Storage and operating junction temperature range		- 40 + 150 - 40 + 125	°C
TI	Maximum lead temperature for soldering during 10s		260	°C

Symbol	Parameter	Voltage				Unit
		D	M	S	N	
$V_{DRM}$ $V_{RRM}$	Repetitive peak off-state voltage $T_j = 125^{\circ}C$	400	600	700	800	V

## T2514xKS / T2516xKS

### THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
Rth(j-c)	Junction to case for D.C	1.7	°C/W
Rth(j-c)	Junction to case for A.C 360° conduction angle (F=50Hz)	1.3	°C/W

### GATE CHARACTERISTICS (maximum values)

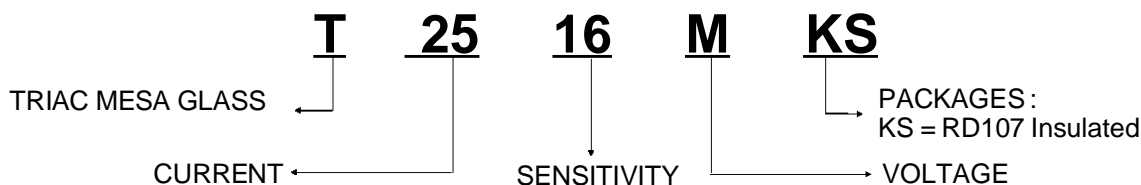
$P_{G(AV)} = 1\text{ W}$   $P_{GM} = 10\text{ W}$  ( $t_p = 20\ \mu\text{s}$ )  $I_{GM} = 4\text{ A}$  ( $t_p = 20\ \mu\text{s}$ )

### ELECTRICAL CHARACTERISTICS

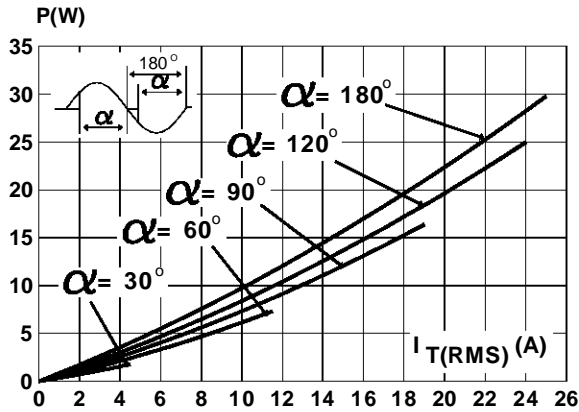
Symbol	Test Conditions	Quadrant		Sensitivity		Unit	
				14	16		
$I_{GT}$	$V_D = 12\text{V (DC)}$ $R_L = 33\Omega$	$T_j = 25^\circ\text{C}$	I-II-III	MIN	2		mA
				MAX	35	50	
$V_{GT}$	$V_D = 12\text{V (DC)}$ $R_L = 33\Omega$	$T_j = 25^\circ\text{C}$	I-II-III	MAX	1.5		V
$V_{GD}$	$V_D = V_{DRM}$ $R_L = 3.3\text{k}\Omega$	$T_j = 125^\circ\text{C}$	I-II-III	MIN	0.2		V
tgt	$V_D = V_{DRM}$ $I_T = 35\text{A}$ $I_G = 500\text{mA}$ $di_G/dt = 3\text{A}/\mu\text{s}$	$T_j = 25^\circ\text{C}$	I-II-III	TYP	2		$\mu\text{s}$
$I_H^*$	$I_T = 250\text{mA}$ Gate open	$T_j = 25^\circ\text{C}$		MAX	35	50	mA
$I_L$	$I_G = 1.2 I_{GT}$	$T_j = 25^\circ\text{C}$	I-III	TYP	35	50	mA
			II	TYP	70	100	
$V_{TM}^*$	$I_{TM} = 35\text{A}$ $t_p = 380\mu\text{s}$	$T_j = 25^\circ\text{C}$		MAX	1.5		V
$I_{DRM}$ $I_{RRM}$	$V_D = V_{DRM}$ $V_R = V_{RRM}$	$T_j = 25^\circ\text{C}$		MAX	10		$\mu\text{A}$
		$T_j = 125^\circ\text{C}$		MAX	3		mA
dV/dt *	$V_D = 67\%V_{DRM}$ Gate open	$T_j = 125^\circ\text{C}$		MIN	500	750	V/ $\mu\text{s}$
(di/dt)c *	Without snubber	$T_j = 125^\circ\text{C}$		MIN	12	22	A/ms
				TYP	24	44	

\* For either polarity of electrode A<sub>2</sub> voltage with reference to electrode A<sub>1</sub>

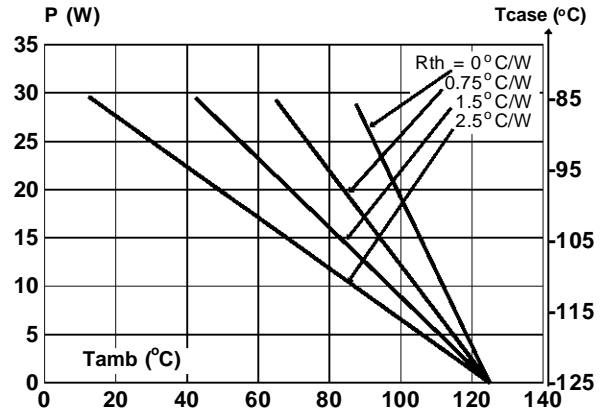
### ORDERING INFORMATION



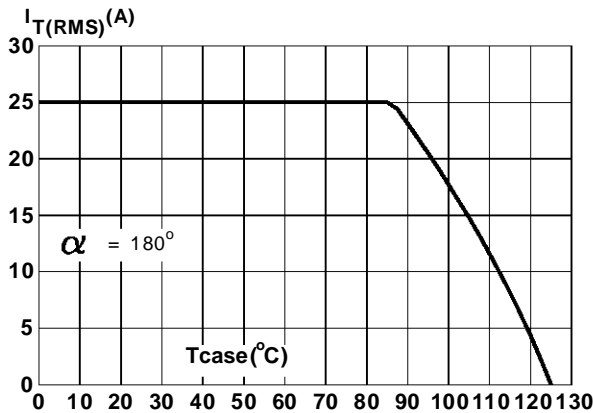
**Fig.1 :** Maximum RMS power dissipation versus average on-state current.



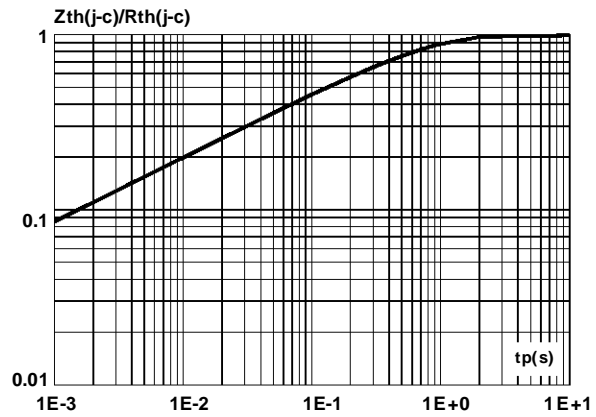
**Fig.2 :** Correlation between maximum RMS power dissipation and maximum allowable temperature (Tamb and Tcase) for different thermal resistances heatsink + contact).



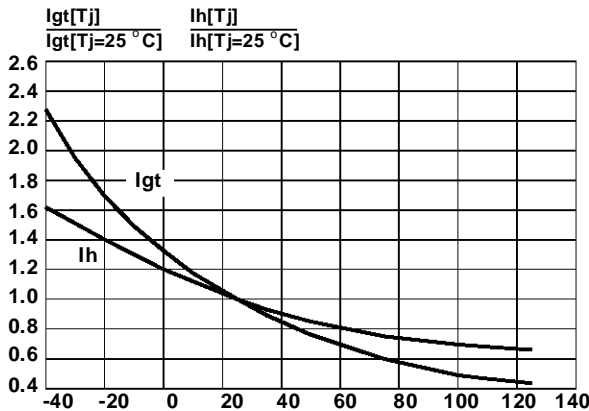
**Fig.3 :** RMS on-state current versus case temperature.



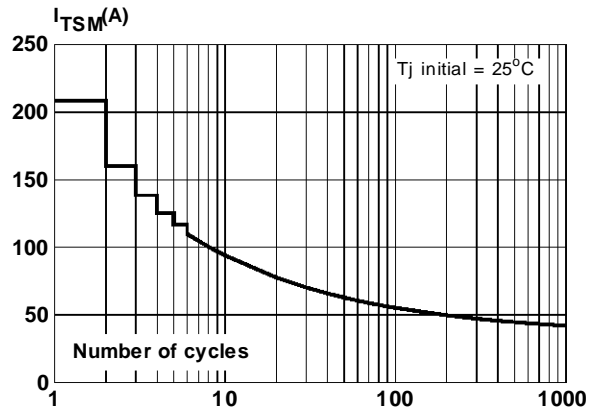
**Fig.4 :** Relative variation of thermal impedance junction to case versus pulse duration.



**Fig.5 :** Relative variation of gate trigger current and holding current versus junction temperature.

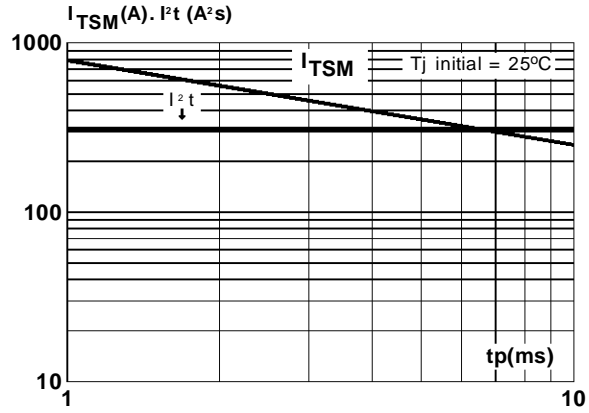


**Fig.6 :** Non repetitive surge peak on-state current versus number of cycles.

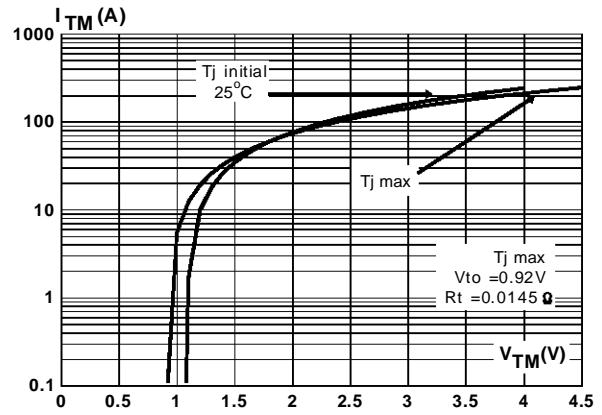


## T2514xKS / T2516xKS

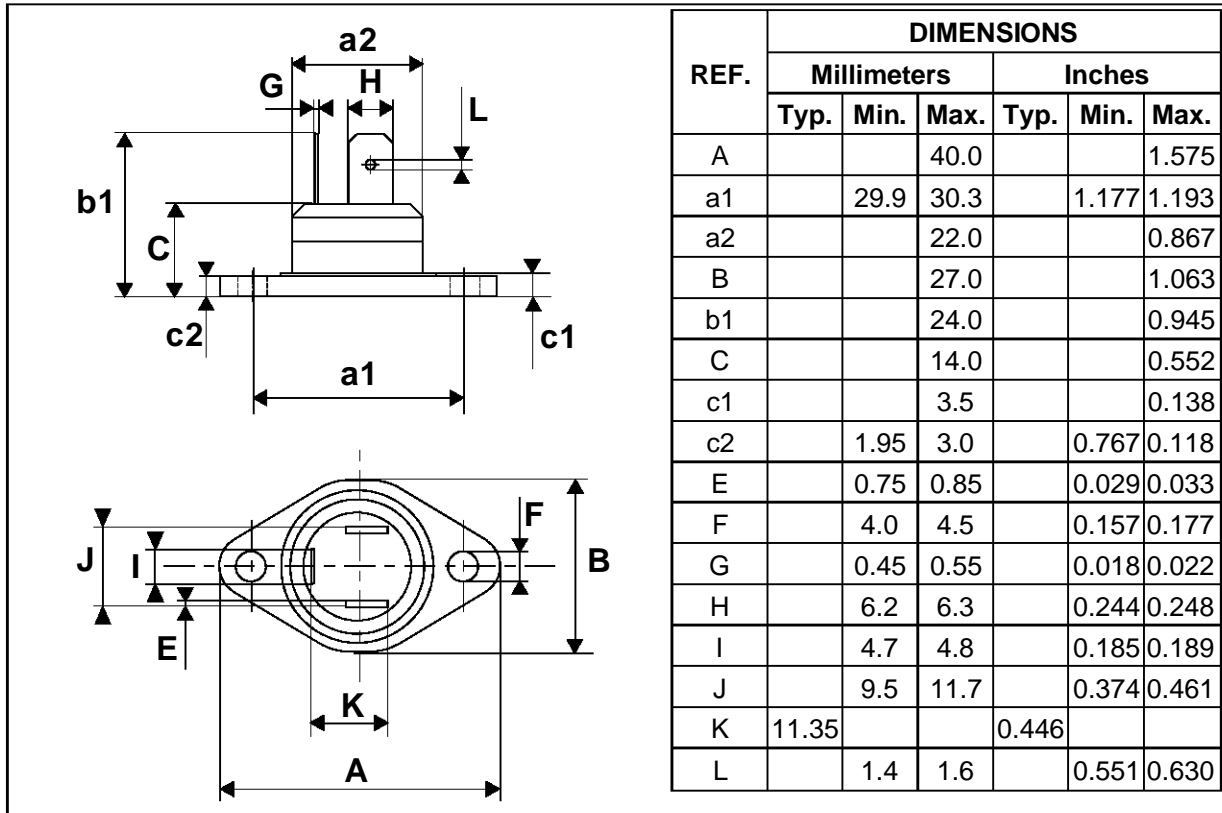
**Fig.7 :** Non repetitive surge peak on-state current for a sinusoidal pulse with width :  $t_p \leq 10\text{ms}$ , and corresponding value of  $I^2t$ .



**Fig.8 :** On-state characteristics (maximum values).



**PACKAGE MECHANICAL DATA**  
RD107 (Plastic)



Marking : type number  
Weight : 20g

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